

Multi-Channel

Silicon ESD Protector
Overvoltage Protection Device

PRODUCT: SESD1103Q6UG-0020-090

DOCUMENT: SCD28428

REV LETTER: A

REV DATE: NOVEMBER 6, 2012

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Specification Status: RELEASED

BENEFITS

- Industry-leading lowest capacitance; provides lowest insertion loss for high speed data signals
- Industry's smallest footprint and lowest profile multi-channel ESD array helps to optimize board space
- Flow-through and single connection design helps routing PCB matched impedance high speed data lines
- Helps protect electronic circuits against damage from Electrostatic Discharge (ESD), surge and cable discharge events
- Assists equipment to pass IEC61000-4-2, level 4 testing

FEATURES

- Low capacitance: 0.20 pF (200fF) (typ)
- Low leakage current: 25nA @ 5V (typ)
- Low clamping voltage: +9.20 / -0.80V (typ)
 @ (tp=8x20µs, Ipp=2A)
- ESD maximum rating per IEC61000-4-2 standard:
 - 20kV contact discharge
 - o 20kV air discharge
- Surge: 2A (max) @ (tp=8x20µs) per IEC61000-4-5
- Small size and low profile: XDFN array packages
 0.38mm height (typ)

APPLICATIONS

- Consumer, mobile and portable electronics
- Tablet PC and external storage with high speed interfaces
- Ultra-high speed data lines
- USB 3.0/2.0, HDMI 1.3/1.4, DisplayPort, Thunderbolt (Light Peak), V-by-One HS, and LVDS interfaces
- Applications requiring high ESD performance in small DFN packages

AEC-Q101 QUALIFIED

MATERIALS INFORMATION

RoHS Compliant ELV Con

ELV Compliant Halogen Free * Lead Free









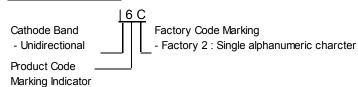
^{*} Halogen Free refers to: Br≤900ppm, Cl≤900ppm, Br+Cl≤1500ppm SESD devices meet MSL-1 Requirements DFN case epoxy meets UL 94 V-0



PART NUMBERING

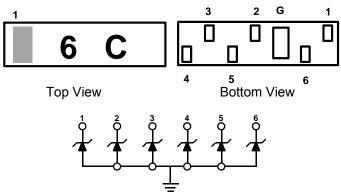


PART MARKING



- Single alphanumeric character

PIN CONFIGURATION AND SCHEMATIC



* Drawing not to scale



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DEVICE MAXIMUM RATING

	ESD Withstand ⁽¹⁾ EC 61000-4-2, level 4)		Temperature	
Contact (kV)	Air (kV)	Operating (°C)	Storage (°C)	lpp (A)
20	20	-55 to +125	-55 to +150	2.0

^{(1) 20}kV @ 1 pulse; 10kV @ 100 pulses; 8kV @ 1,000 pulses (under IEC6100-4-2)

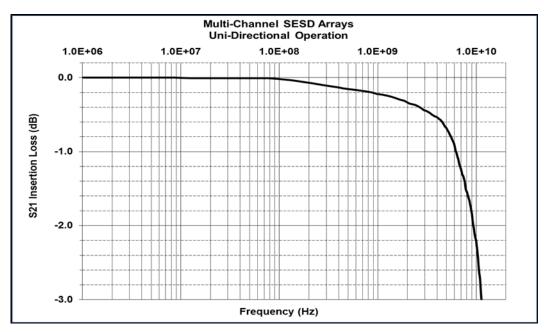
- Maximum leakage current post 15kV & 20kV pulses is less than 1 μA
- Device maximum rating @ T = 25°C, unless otherwise specified
- Caution: Stress exceeding Device Maximum Ratings may damage the device Prolonged exposure to stresses above the Recommended Operating Conditions may affect device reliability

DEVICE ELECTRICAL CHARACTERISTICS

Input Capacitance		Breakdown Voltage	eakdown Voltage Reverse Working		Reverse Leakage Current		Clamping Voltage
@ $V_R = 0V$, $f = 3GHz$, I/O to GND (pF)		V _{BR} @ I _T =1mA (V)	Voltage (V)		I _L @ V _{RWM} =5.0V (nA)		V _{CL} @ lpp=2.0A (V)
Тур	Maximum	Тур	Min	Max	Тур	Max	Тур
0.20	0.25	+9.00 / -0.80	0	+7.00	25.0	50.0	+9.20 / -0.80

• All device electrical characteristics @ T = 25°C, unless otherwise specified

FIGURE 1. INSERTION LOSS DIAGRAM



Application	Bit Rate (Gbps)	@Freq (GHz)	Ins. Loss (dB)
HDMI 1.4 (1080P)	2.25	1.13	-0.23
DisplayPort	2.70	1.35	-0.26
HDMI 1.4 (4K / QuadHD)*	3.40	1.70	-0.30
USB3.0	5.00	2.50	-0.38
eSATA	6.00	3.00	-0.44
Thunderbolt	10.0	5.00	-0.69

^{*}HDMI 4K / QuadHD resolutions (4096 x 2160) ready



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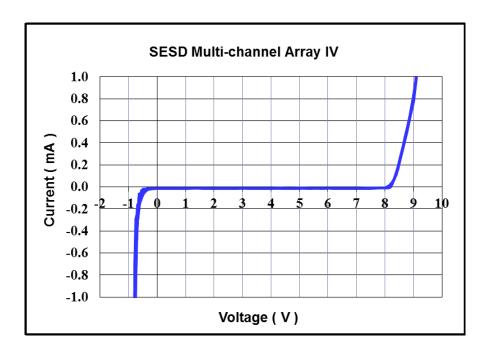
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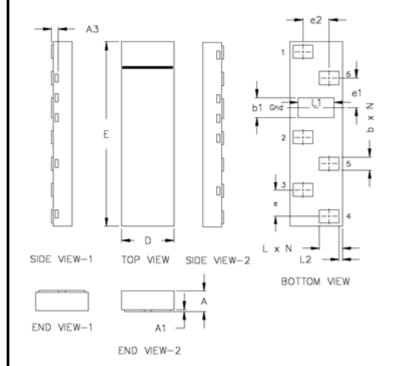
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FIGURE 2. DEVICE IV CURVE



DEVICE DIMENSIONS



	SESD1103Q6UG-0020-090						
	N	/lillimeter	s	Inches			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.33	0.38	0.43	0.013	0.015	0.017	
A 1	0	0.02	0.05	0		0.002	
A3		0.127 re	f	(0.005 ret	f	
D	0.70	0.80	0.90	0.027	0.031	0.035	
Е	2.70	2.80	2.90	0.106	0.110	0.114	
b	0.15	0.20	0.25	0.006	0.008	0.010	
b1	0.25	0.30	0.35	0.010	0.012	0.014	
L	0.30	0.35	0.40	0.012	0.014	0.016	
L1	0.50	0.55	0.60	0.019	0.021	0.024	
L2	0.05 BSC			0	.002 BS	С	
е	(0.40 BSC		0	.016 BS	С	
e1	0.45 BSC			0	.018 BS	С	
e2	0.40 BSC			0	.016 BS	С	
N		6			6		

BSC - Basic Spacing between Centers



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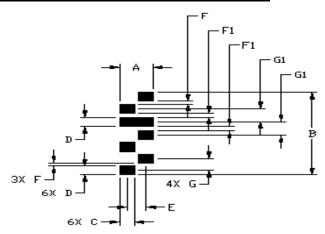
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RECOMMENDED LANDING PATTERN:



SESD Landing Pad Layout					
7 Pin 6-ch Miniature FT Array					
Symbol	Millimeters	Inches			
Α	0.80	0.031			
В	2.80	0.110			
С	0.35	0.014			
D	0.30	0.012			
E	0.45	0.018			
F	0.10	0.004			
F1	0.15	0.006			
G	0.40 BSC	0.016 BSC			
G1	0.45 BSC	0.018 BSC			
G	0.40 BSC	0.016 BSC			

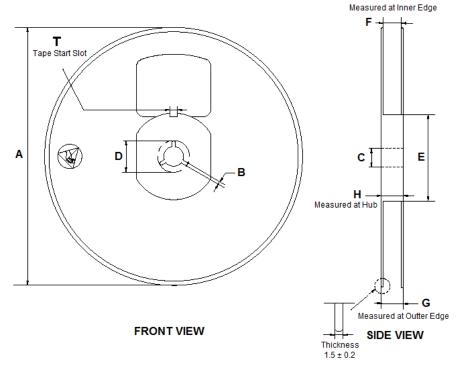
SESD Landing Bad Layout

PAD LAYOUT

PACKAGING

Packaging	Tape & Reel	Standard Box
SESD1103Q6UG-0020-090	5,000	25,000

REEL DIMENSIONS



Dimensions	Α	В	С	D	E	F	(3	Н
(mm)	179 ± 1.00	1.50 (min)	13.0 ± 0.20	20.20 (min)	60 ± 0.50	9.2 +2.00 / -0.00	8.70 (min)	12.20 (max)	12.2 (max)



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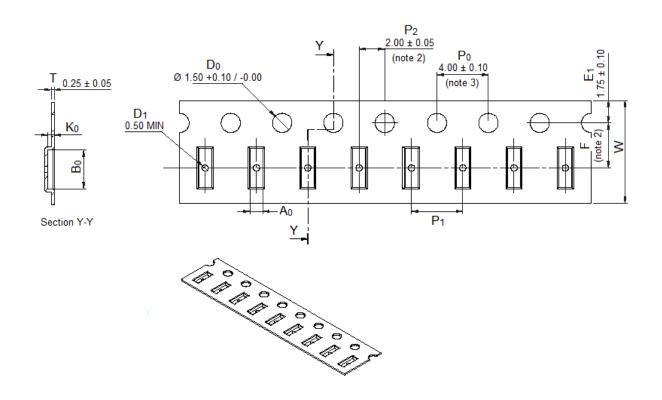
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CARRIER TAPE DIMENSIONS



A_0	1.00 ± 0.05
B ₀	3.00 ± 0.05
K ₀	0.51 ± 0.05
F	3.50 ± 0.05
P ₁	4.00 ± 0.10
W	8.00 + 0.30 / - 0.10

Note 1. All dimensions in mm

Note 2. Measured from centerline of pocket to centerline of sprocket

Note 3. Cumulative tolerance of 10 sprocket holes is \pm 0.20

Note 4. Tolerances unless noted ± 0.20



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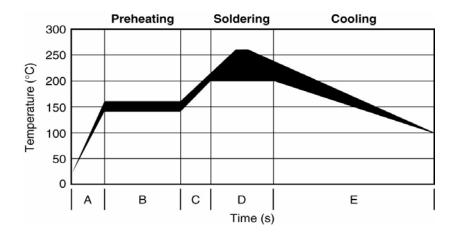
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SOLDER REFLOW RECOMMENDATION

Α	Temperature	From ambient to	30s to 60s	
	ramp up 1	Preheating temperature	303 10 003	
В	Preheating	140°C - 160°C	60s to 120s	
С	Temperature	From Preheating to Main	20s to 40s	
	ramp up 2	heating temperature	203 10 405	
		at 200°C	60s ~ 70s	
D	Main heating	at 220°C	50s ~ 60s	
ט		at 240°C	30s ~ 40s	
		at 260°C	5s ~ 10s	
Е	Cooling	From main heating	4°C/s (max)	
-	Cooling	temperature to 100°C	4 C/S (IIIdX)	

FIGURE 3. REFLOW PROFILE



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